

[54] **ELECTRONIC TESTING DEVICE FOR A MICROPROCESSOR**

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[73] **Assignee: Ugly Products, Gardena, Calif.**

[**] **Term: 14 Years**

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[52] **U.S. Cl. D10/75; D13/24**

[58] **Field of Search D10/46, 75, 78, 81, D10/102, 103; D13/24; 324/73 R, 73 PC, 158 F; 339/17 R, 17 CF, 17 LC, 18 R, 18 B, 147 R**

[56] **References Cited**

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[57] **CLAIM**

The ornamental design for an electronic testing device for a microprocessor, as shown and described.

DESCRIPTION

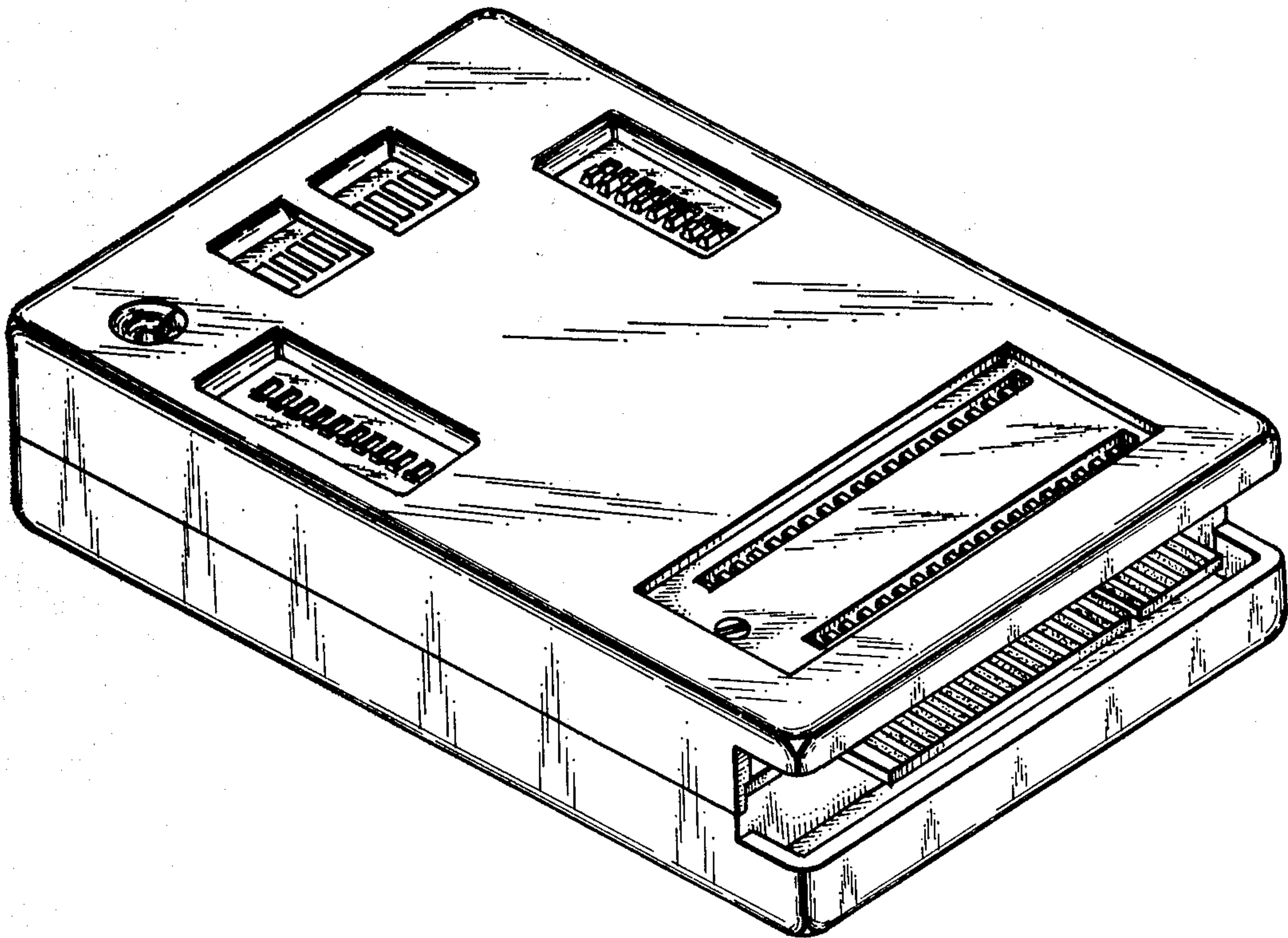
FIG. 1 is a top and right front perspective view of an electronic testing device for a microprocessor showing my new design;

FIG. 2 is a right side elevational view thereof;

FIG. 3 is a rear elevational view thereof;

FIG. 4 is a left side elevational view thereof;

FIG. 5 is a bottom plan view thereof.



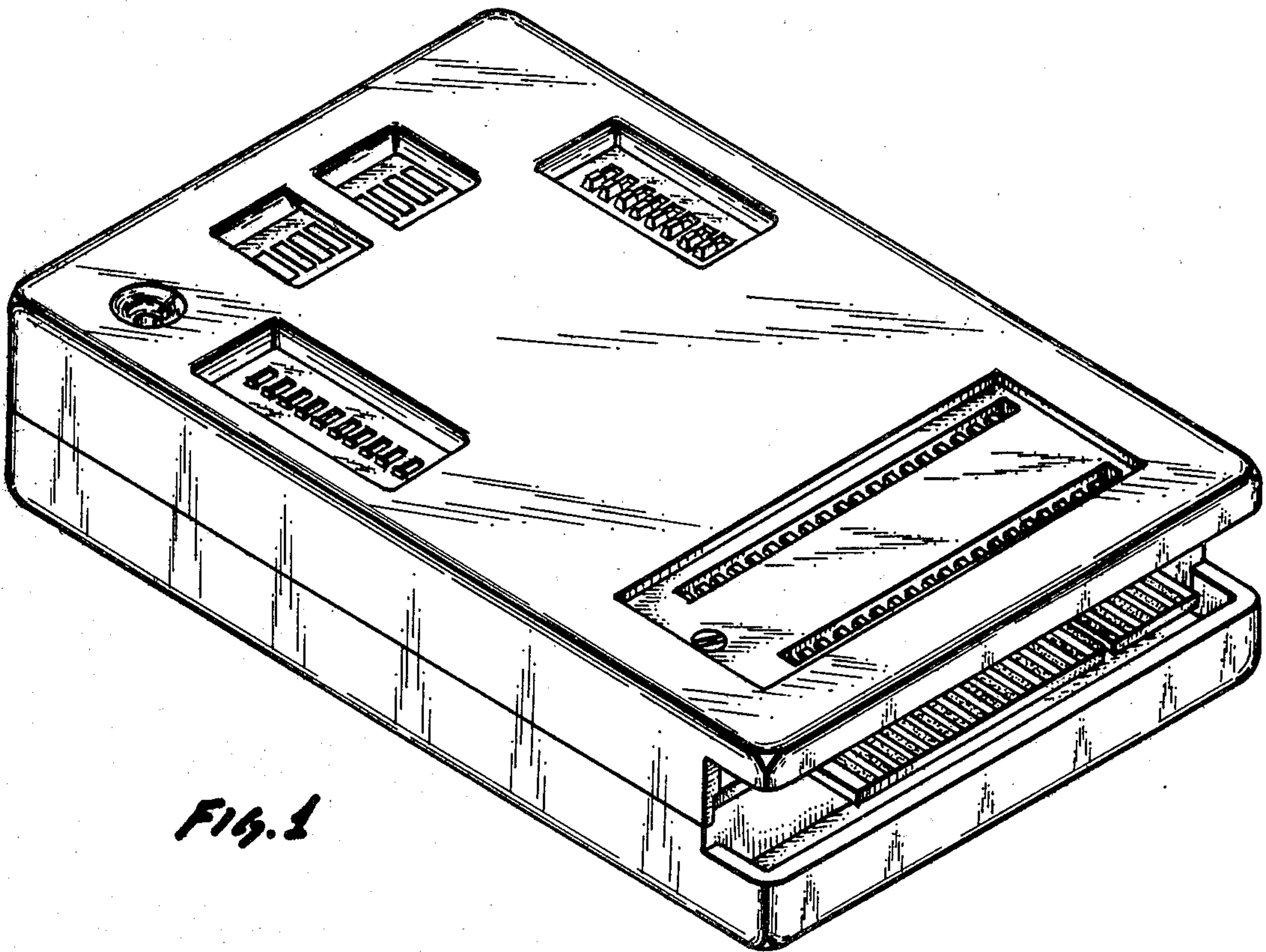


Fig. 1

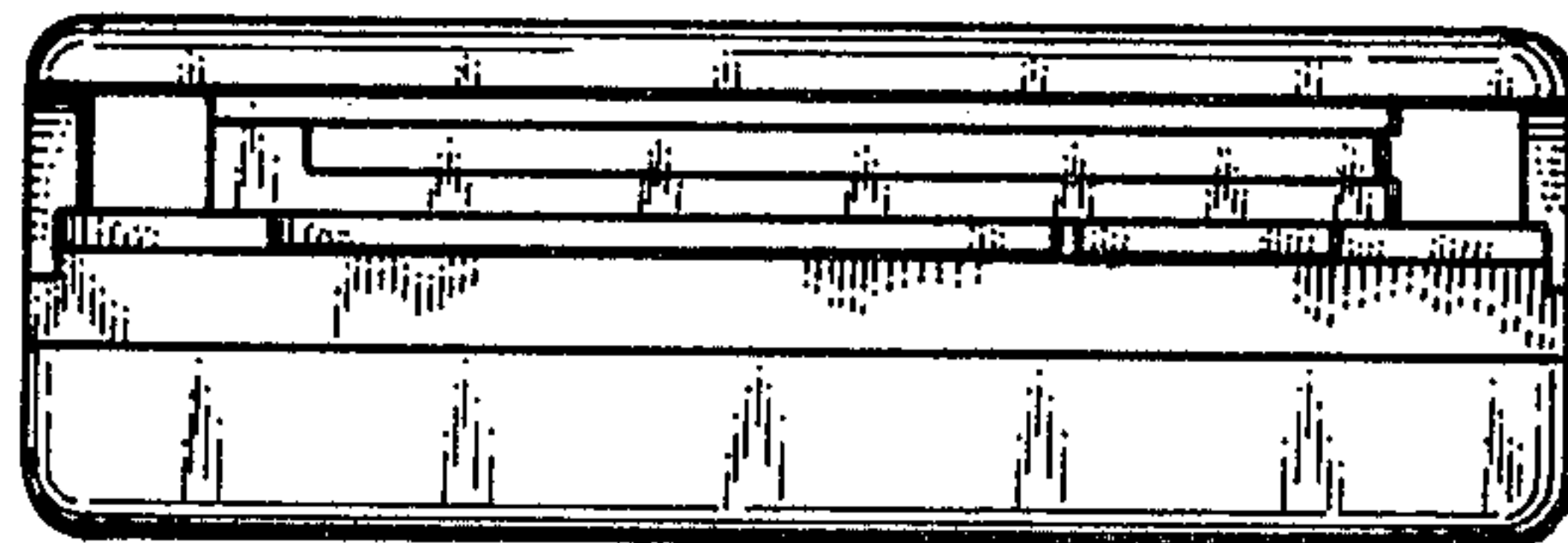


Fig. 2

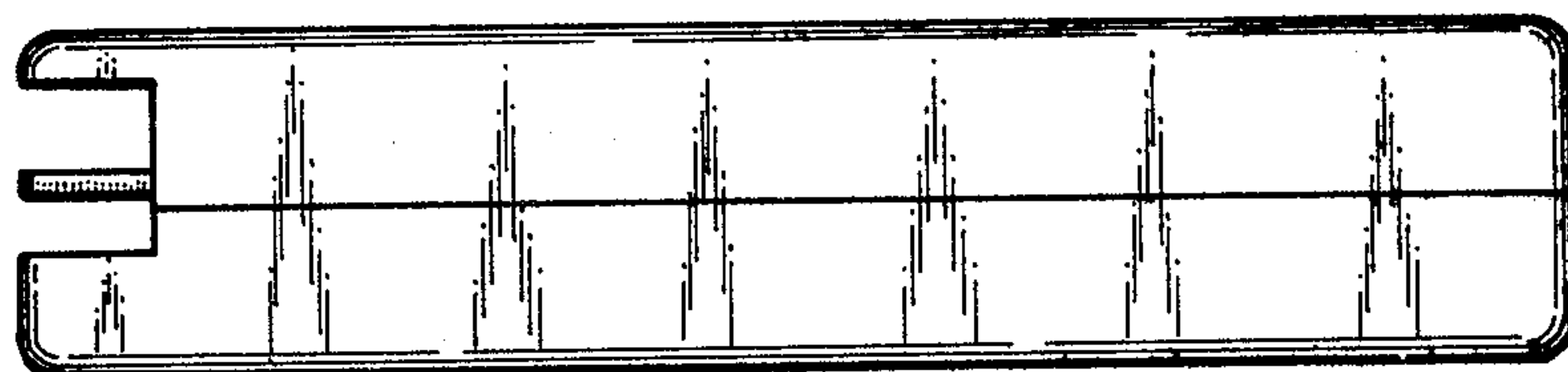


Fig. 3

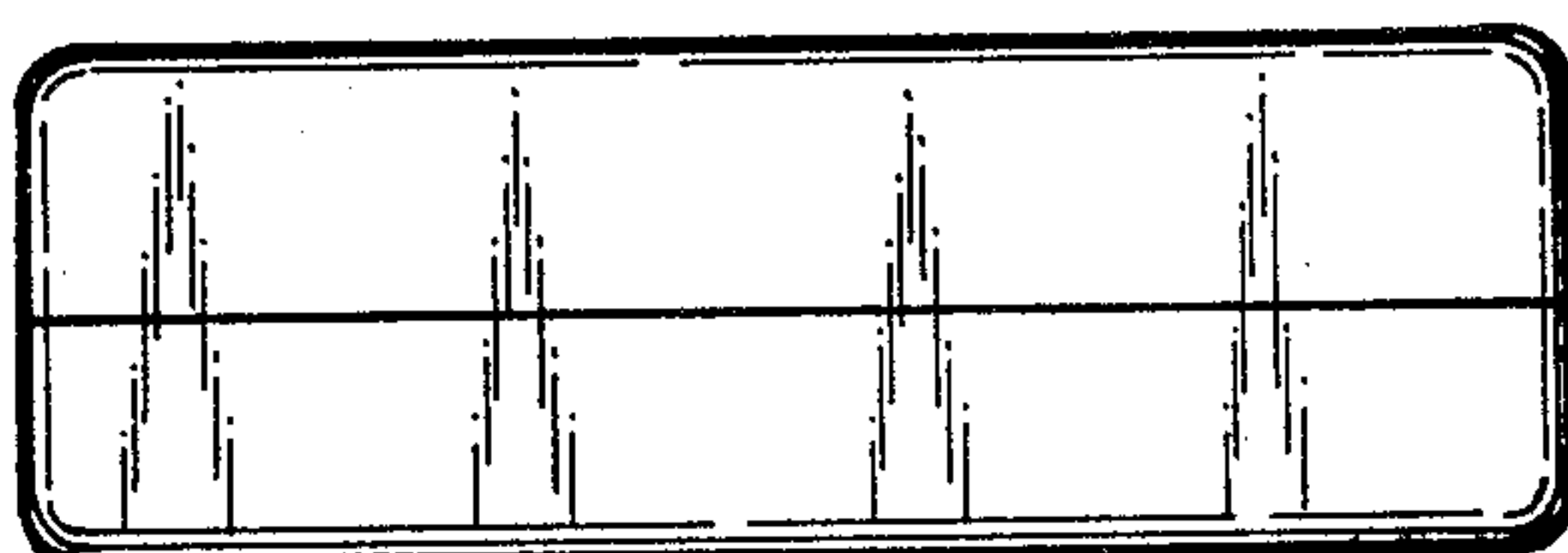


Fig. 4

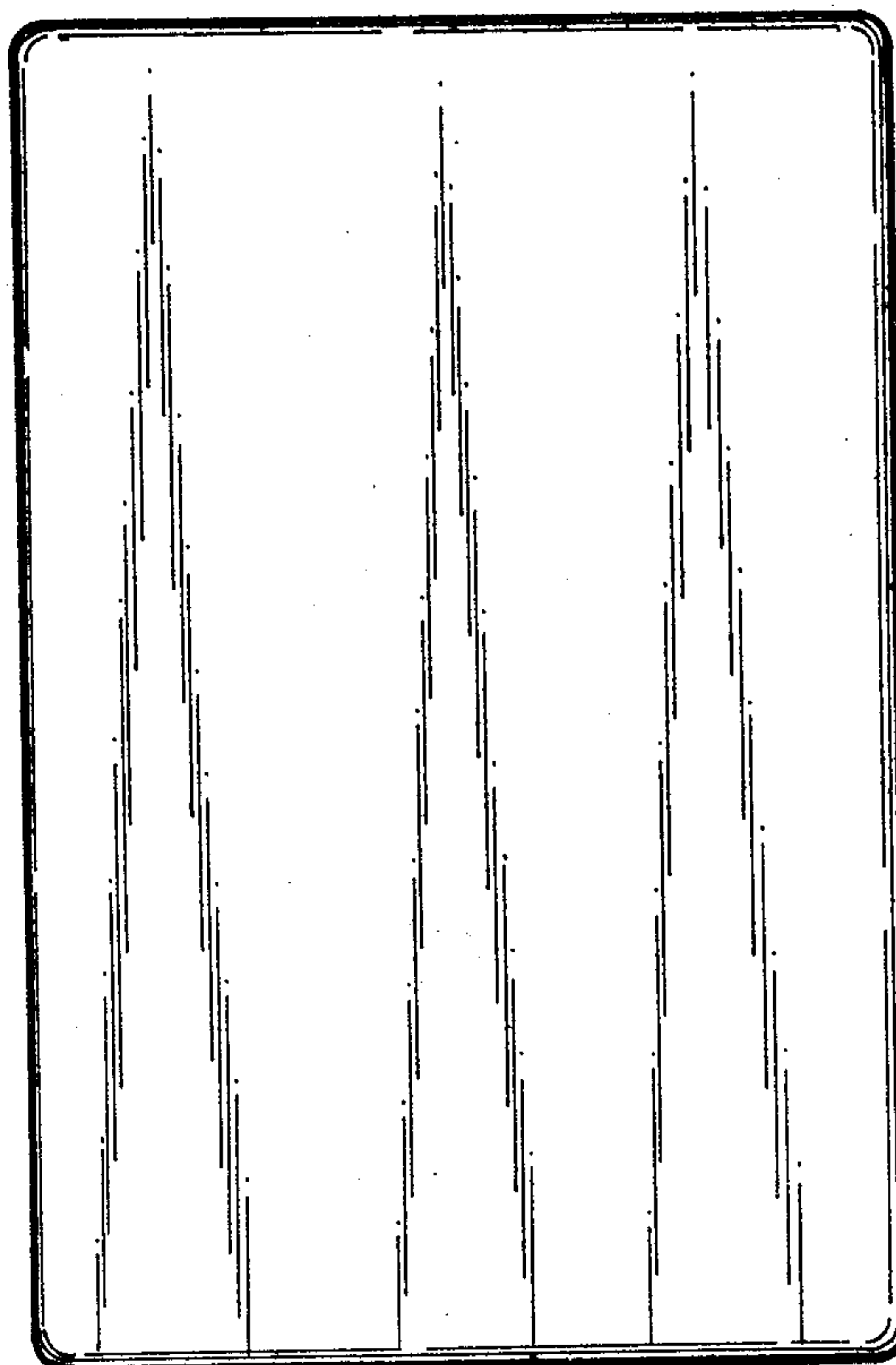


Fig. 5